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**REFERENCES CITED BY APPLICANT**  
 (Use several sheets if necessary)

ATTY. DOCKET NO.	APPLICATION NO.
017170-0010-999	10/077,596
<b>APPLICANT</b>	
Snow, et al.	
<b>FILING DATE</b>	<b>ART UNIT</b>
February 15, 2002	1617

**U.S. PATENT DOCUMENTS**

*Examiner Initials	Document Number	Date mm/dd/yy	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
A01	US 5,922,756	04/13/99	Chan	514/456
A02				
A03				
A04				
A05				

**FOREIGN PATENT DOCUMENTS**

*Examiner Initials	Foreign Patent Document Country Code, Number, Kind Code (if known)	Date mm/dd/yy	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T
B01	WO 00/30666	02/06/00	Univ. Washington		
B02	WO 99/45797	09/16/99	Mars inc.		
B03					
B04					

**NON PATENT LITERATURE DOCUMENTS**

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EXAMINER /Yong Chong/	DATE CONSIDERED 03/20/2008
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